

Application No.: To Be Assigned

10/564507
IAP20 Rec'd PCT/PTO 12 JAN 2006
MAT-8793US

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appln. No: To Be Assigned
Applicants: Toshiaki SHIMIZU, et al.
Filed: Herewith
Title: METHOD FOR DETERMINING DETERIORATION OF CAPACITOR
TC/A.U.: To Be Assigned
Examiner: To Be Assigned
Confirmation No.: To Be Assigned
Docket No.: MAT-8793US

PRELIMINARY AMENDMENT

Mail Stop PCT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Prior to examination, please amend the above-identified application as follows:

- ☐ **Amendments to the Title** begin on page of this paper.
- ☒ **Amendments to the Specification** begin on page **2** of this paper.
- ☒ **Amendments to the Claims** are reflected in the listing of claims which begins on page **3** of this paper.
- ☐ **Amendments to the Drawings** begin on page of this paper and include an attached replacement sheet(s).
- ☒ **Amendments to the Abstract** are on page **5** of this paper. A clean version of the Abstract is on page **6** of this paper.
- ☐ **Remarks/Arguments** begin on page of this paper.